Notice of References Cited Application/Control No. 10/630,189 Examiner Christina Y. Leung Applicant(s)/Patent Under Reexamination YAP ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,862,467 A	08-1989	Carter et al.	372/18
	В	US-			
	O	US-			
	D	US-			
	ш	US-			
	F	US-			
	G	US-			
	Ξ	US-		·	
	1	US-			
	٦	US-			
	К	US-		·	
	L	US-			
	М	US-	:		

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	Q					
	R					
	s			·		
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.